

**Search Notes**

Application/Control No.

10/629,054

Examiner

Charles N. Appiah

Applicant(s)/Patent under  
Reexamination

HIRAYAMA ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	450,451 ,452.1,447	3/30/2006	CA
	449,446,		
	464,422.1		
	522		
370	329,328		
	334,347		
	341,330		
	342		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See attached		3/30/2006	CA

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
455/450,451,452.1,447,449,446,422.1 ,522	3/30/2006	CA
370/328,329,330,334,341,342,347,		
see attached report		